

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

In re Application of

Yoshihiko KANZAWA, et al.

Serial No.: 10/674,523

Filed: October 01, 2003



: Customer Number: 20277

: Confirmation Number: 5372

: Group Art Unit: To be Assigned

: Examiner: To be Assigned

For: METHOD FOR MEASURING SEMICONDUCTOR CONSTITUENT ELEMENT  
CONTENT AND METHOD FOR MANUFACTURING A SEMICONDUCTOR DEVICE (As  
amended)

**REQUEST FOR CORRECTED FILING RECEIPT**

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P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

Attached is a copy of the Filing Receipt received from the U.S. Patent and Trademark Office in the above-referenced application. It is noted that the total and independent claims data is incorrect. Total claims should read: 16 and independent claims 2. It is requested that a corrected filing receipt be issued. Please update the title on the official filing receipt as amended above.

Respectfully submitted,

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**Date: May 5, 2004**



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| APPL NO.   | FILING OR 371<br>(c) DATE | ART UNIT | FIL FEE REC'D | ATTY. DOCKET NO | DRAWINGS | TOT CLMS | IND CLMS |
|------------|---------------------------|----------|---------------|-----------------|----------|----------|----------|
| 10/674,523 | 10/01/2003                |          | 770           | 63979-033       | 14       | 16       | 12       |

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CONFIRMATION NO. 5372

## FILING RECEIPT



\*OC000000012437981\*

Date Mailed: 04/26/2004

Receipt is acknowledged of this regular Patent Application. It will be considered in its order and you will be notified as to the results of the examination. Be sure to provide the U.S. APPLICATION NUMBER, FILING DATE, NAME OF APPLICANT, and TITLE OF INVENTION when inquiring about this application. Fees transmitted by check or draft are subject to collection. Please verify the accuracy of the data presented on this receipt. If an error is noted on this Filing Receipt, please write to the Office of Initial Patent Examination's Filing Receipt Corrections, facsimile number 703-746-9195. Please provide a copy of this Filing Receipt with the changes noted thereon. If you received a "Notice to File Missing Parts" for this application, please submit any corrections to this Filing Receipt with your reply to the Notice. When the USPTO processes the reply to the Notice, the USPTO will generate another Filing Receipt incorporating the requested corrections (if appropriate).

### Applicant(s)

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Domestic Priority data as claimed by applicant

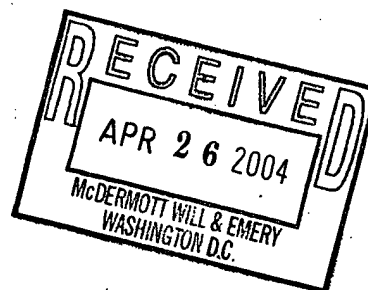
Foreign Applications

If Required, Foreign Filing License Granted: 04/23/2004

Projected Publication Date: Request for Non-Publication Acknowledged

Non-Publication Request: Yes

Early Publication Request: No



### Title

Method for measuring the content ratio of semiconductor elements and a method for fabricating a semiconductor device

Preliminary Class

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**Title 37, Code of Federal Regulations, 5.11 & 5.15**

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